Application/Control No. Applicant(s)/Patent Under Reexamination 10/089,539 LOPEZ, PATRICK Notice of References Cited Examiner Art Unit Page 1 of 1 Melanie Jagannathan 2616 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 370/331 09-1992 Akerberg, Dag E. US-5,150,362 Α 455/63.3 US-6,574,456 06-2003 Hamabe, Kojiro В US-6\741,837 05-2004 Nakano et al. 375/227 С 01-1993 Gunmar et al. 455/446 US-5,179,722 D 07-2002 Yoshida et al. 455/522 US-6,418,320 Ε 02-2002 Monot et al. 455/423 US-6,349,207 F US-G US-Н US-US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS

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